SPECIFICATIONS

Product Name		Wire Wound Chip Ceramic Inductor					
Sunlord Part Nu	mber		MWSD16	08C	T	S01	
Customer Part N	Number						
⊠New Released	I, ∐Revise	d]		SPEC N	No.: MV	VSD031822	
This SPEC is tot		_	-	s and appe	ndix. 】		
ROHS, Halogen-F	ree and SVHC	Complia	nt Parts]				
Γ	Approved E	By Che	ecked By	Issued	d By		
					·		
				<u> </u>			
Shenzhe address:Sunlord Ind fel: 0086-755-29832	ustrial Park,Da	afuyuan Ir		e,Guanlan,	Shenzhe		
ddress:Sunlord Ind	ustrial Park,Da 2333 Fax:0	afuyuan Ir	ndustrial Zon 82269029	e,Guanlan,	Shenzhe	en,China 5181	
ddress:Sunlord Ind el: 0086-755-29832	ustrial Park,Da 2333 Fax:0	afuyuan Ir 1086-755-	ndustrial Zon 82269029	e,Guanlan, E-Mail:s	Shenzhe unlord@	en,China 5181	
ddress:Sunlord Ind el: 0086-755-29832 or Customer appro	ustrial Park,Da 2333 Fax:0	afuyuan Ir 086-755-≀ ☐ Res	ndustrial Zon 32269029	e,Guanlan, E-Mail:s Date: Rejecte	Shenzhe unlord@	en,China 5181	
ddress:Sunlord Ind el: 0086-755-29832 or Customer appro nalification Status:	ustrial Park,Da 2333 Fax:0 oval Only I	afuyuan Ir 086-755-≀ ☐ Res	ndustrial Zon 82269029 tricted	e,Guanlan, E-Mail:s Date: Rejecte	Shenzhe unlord@	en,China 5181 sunlordinc.co	
ddress:Sunlord Ind el: 0086-755-29832 or Customer appro nalification Status:	ustrial Park,Da 2333 Fax:0 oval Only I	afuyuan Ir 086-755-≀ ☐ Res	ndustrial Zon 82269029 tricted	e,Guanlan, E-Mail:s Date: Rejecte	Shenzhe unlord@	en,China 5181 sunlordinc.co	
ddress:Sunlord Ind el: 0086-755-29832 or Customer appro nalification Status:	ustrial Park,Da 2333 Fax:0 oval Only I	afuyuan Ir 086-755-≀ ☐ Res	ndustrial Zon 82269029 tricted	e,Guanlan, E-Mail:s Date: Rejecte	Shenzhe unlord@	en,China 5181 sunlordinc.co	
or Customer appropriation of Status: Approved By	ustrial Park,Da 2333 Fax:0 oval Only I	afuyuan Ir 086-755-≀ ☐ Res	ndustrial Zon 82269029 tricted	e,Guanlan, E-Mail:s Date: Rejecte	Shenzhe unlord@	en,China 5181 sunlordinc.co	
ddress:Sunlord Ind el: 0086-755-29832 or Customer appro nalification Status:	ustrial Park,Da 2333 Fax:0 oval Only I	afuyuan Ir 086-755-≀ ☐ Res	ndustrial Zon 82269029 tricted	e,Guanlan, E-Mail:s Date: Rejecte	Shenzhe unlord@	en,China 5181 sunlordinc.co	

【Version change history】

Rev.	Effective Date	Changed Contents	Changed Contents Change reasons App	
01	1	New release	/	Qintian Hou

Caution

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

- 1. Aircraft equipment
- 2. Aerospace equipment
- 3. Undersea equipment
- 4. nuclear control equipment
- 5. military equipment
- 6. Power plant equipment
- 7. Medical equipment
- 8. Transportation equipment (automobiles, trains, ships, etc.)
- 9. Traffic signal equipment
- 10. Disaster prevention / crime prevention equipment
- 11. Data-processing equipment
- 12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

Scope

This specification applies to the MWSD1608C $\hfill\square$ TS01 of Wire Wound Chip Ceramic Inductor.

2. Product Description and Identification (Part Number)

1) Description

Wire Wound Chip Ceramic Inductor

2) Product Identification (Part Number)

<u>MWS</u>	<u>D 1608 C □□□</u>				<u>T</u>	<u>S01</u>	
1	2	3	4	(5)	6	7	8

① Type	
MWS	Wire Wound Chip Radio Frequency Inductor

③External Dimensions [L X W] (mm)			
1608	1.6 X 0.8		

⑤ Nominal Inductance (nH)				
1N0	1.0			
10N	10			
R10	100			

⑦ Packing					
В	Bulk Package				
Т	Tape & Reel				

②Process	
D	Dip

④ Material Code					
Example	Nominal Value				
С	Ceramic				

⑥ Inductance Tolerance				
С	±0.2nH			
D	±0.5nH			
G	±2%			
J	±5%			

8 Internal	Code
S01	Internal Code

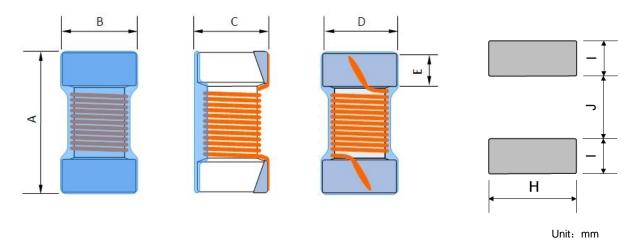
3. Electrical Characteristics

Please refer to Appendix A.

- Operating and storage temperature range (individual chip without packing): -40°C to +125°C

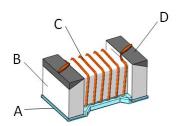
4. Shape and Dimensions

1) Dimensions: See the following.



Α	В	C	D REF.	E REF	H REF.	l REF.	J REF.
1.60±0.20	0.80±0.20	0.80±0.20	0.80	0.30	1.02	0.64	0.64

3) Structure: See the following.



No.	Components	Material
Α	Coating	Ultraviolet epoxy resin
В	Core	Ceramic
С	Wire	Polyurethane system enameled copper wire
D	Electrodes	Ag/Ag-Pd/Mo-Mn with Ni and Sn plating

5. Test and Measurement Procedures

5.1 Test Conditions

Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

a. Ambient Temperature: 20±15℃
b. Relative Humidity: 65%±20%
c. Air Pressure: 86KPa to 106KPa

If any doubt on the results, measurements/tests should be made within the following limits:

a. Ambient Temperature: 20±2℃
b. Relative Humidity: 65%±5%
c. Air Pressure: 86KPa to 106KPa

5.2 Visual Examination

a. Inspection Equipment: 30 X magnifier

5.3 Electrical Test

5.3.1 DC Resistance (DCR)

- a. Refer to Appendix A
- b. Test equipment: HIOKI3540 or equivalent

5.3.2 Inductance (L)

- a. Refer to Appendix A.
- b. Test equipment: Agilent 4287A +Agilent 16197A or equivalent
- c. Test signal: -13dBm or 10mA
- d. Test frequency refers to Appendix A

5.3.3 Q Factor (Q)

- a. Refer to Appendix A
- b. Test equipment: Agilent 4287A +Agilent 16197A or equivalent
- c. Test signal: -13dBm or 10mA
- d. Test frequency refers to **Appendix A**.

5.3.4 Self-Resonant Frequency (SRF)

- a. Refer to Appendix A.
- b. Test equipment: Agilent E4991A+Agilent 16197A and HP 8753E or equivalent.
- c. Test signal: -20dBm or 50 mV

5.3.5 Rated Current

- a. Refer to Appendix A
- b. Test equipment (see Fig.5.3.5-1): Electric Power, Electric current meter, Thermometer.
- c. Measurement method (see Fig. 5.3.5-1):
 - 1. Set test current to be 0mA.
 - 2. Measure initial temperature of chip surface.
 - 3. Gradually increase voltage and measure chip temperature for corresponding current.
- d. Definition of Rated Current (Ir): Ir is direct electric current as chip surface temperature rose just 20°C against chip initial surface temperature (Ta) (see **Fig. 5.3.5-2**).

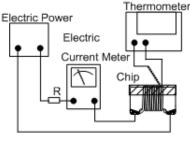


Fig.5.3.5-1

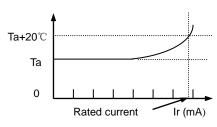
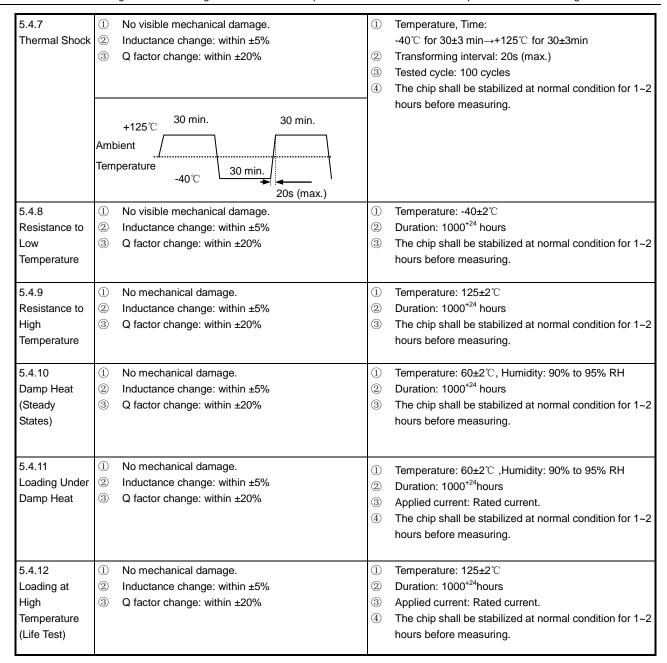


Fig. 5.3.5-2

5.4 Reliability Test

Items	Requirements	Test Methods and Remarks
5.4.1 Terminal Strength	No removal or split of the termination or other defects shall occur. Chip Mounting Pad Glass Epoxy Board	 Solder the inductor to the testing jig (glass epoxy board) using eutectic solder. Then apply a force in the direction of the arrow. 7N force. Keep time: 10±1s Speed: 1.0 mm/s.
5.4.2 Resistance to Flexure	No visible mechanical damage. R10 Unit: mm R45 Flexure	Solder the inductor to the test jig. Using a eutectic solder. Then apply a force in the direction shown as left. Flexure: 2mm Pressurizing Speed: 0.5mm/sec. Keep time: 5sec.
5.4.3 Vibration	No visible mechanical damage. Inductance change: within ±5% Q factor change: within ±20% Cu pad Solder mask Glass Epoxy Board	 Solder the inductor to the testing jig (glass epoxy board)using eutectic solder. The inductor shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours)
5.4.4 Dropping	 No visible mechanical damage. Inductance change: within ±5% Q factor change: within ±20% 	Drop chip inductor 10 times on a concrete floor from a height of 100 cm.
5.4.5 Solderability	90% or more of electrode area shall be Coated by new solder.	 Electrode of the coil shall be immersed in flux for 5 to 10 Seconds. The coil shall be immersed in solder bath at a temperature of 240±5°C, Duration for 3±0.5 seconds. Solder: Sn/3.0Ag/0.5Cu Flux: 25% Resin and 75% ethanol in weight.
5.4.6 Resistance to Soldering Heat	No visible mechanical damage. Inductance change: within ±5% Q factor change: within ±20%	Re-flowing Profile: 260 °C Peak 260 °C max Max Ramp Up Rate=3 °C/sec. Max Ramp Down Rate =6 °C/sec. 200 150 60 ~ 90 sec. 25 °C Time 25 °C to Peak= 8 min Max



6. Packaging and Storage

6.1 Packaging

There are two types of packaging for the chip inductors. Please specify the packing code when ordering.

Tape Carrier Packaging:

Packaging code: T

- a. Tape carrier packaging are specified in attached figure Fig.6.1-1~4
- b. Tape carrier packaging quantity please see the following table:

Туре	1608
Tape	Paper Tape
Quantity	3K

(1) Taping Drawings (Unit: mm)

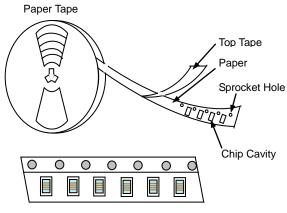


Fig. 6.1-1

Remark: The sprocket holes are to the right as the tape is pulled toward the user.

(2) Taping Dimensions (Unit: mm)

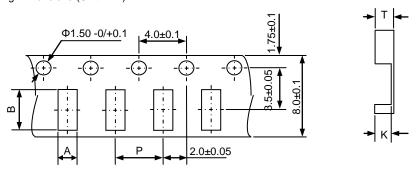
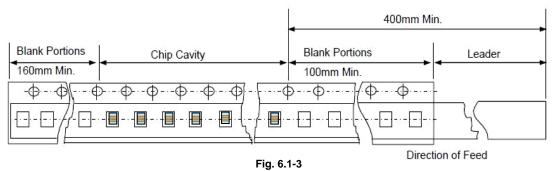


Fig. 6.1-2

Туре	Α	В	Р	К	Т
1608	1.00±0.10	1.90±0.10	4.0±0.10	1.00±0.10	1.03±0.10

(3) Leader and blank portion



(4) Reel Dimensions (Unit: mm)

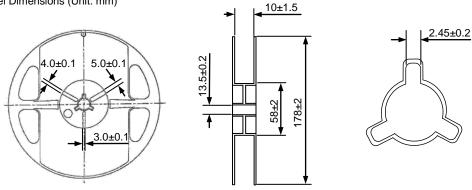
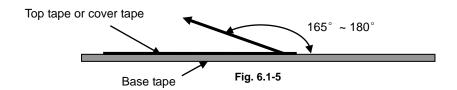


Fig. 6.1-4

(5) Peeling off force: 10gf to 70gf in the direction show below.



6.2 Storage

- a. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40°C or less and 70% RH or less.
- b. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCI, sulfurous gas of H_2S)
- c. Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- d. Minimum packages, such as polyvinyl heat-seal packages shall not be opened until they are used. If opened, use the reels as soon as possible.
- e. Solderability shall be guaranteed for <u>12</u> months from the date of delivery on condition that they are stored at the environment specified in specification. For those parts, which passed more than <u>12</u> months shall be checked solder-ability before use.

7. Warning and Attentions

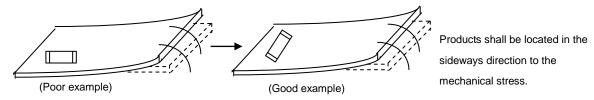
7.1 Precautions on Use

- a. Always wear static control bands to protect against ESD.
- b. Any devices used (soldering iron, measuring instruments) should be properly grounded.
- c. Use non-magnetic tweezers when handing the chips.
- d. Pre-heating when soldering, and refer to the recommended condition specified in specification.
- e. Don't apply current in excess of the rated current value. It may cause damage to components due to over-current.
- f. Keep clear of anything that may generate magnetic fields such as speakers, coils.
- g. When soldering, the electrical characteristics may be varied due to hot energy and mechanical stress.
- h. When coating products with resin, the relatively high resin curing stress may change the electrical characteristics. For exterior coating, select resin carefully so that electrical and mechanical performance of the product is not affected. Before using, please evaluate reliability with the product mounted in your application set.
- i. When mount chips with adhesive in preliminary assembly, do appropriate check before the soldering stage, i.e., the size of land pattern, type of adhesive, amount applied, hardening of the adhesive on proper usage and amounts of adhesive to use.
- j. Mounting density: Add special attention to radiating heat of products when mounting other components nearby. The excessive heat by other products may cause deterioration at joint of this product with substrate.
- k. Since some products are constructed like an open magnetic circuit, narrow spacing between components may cause magnetic coupling.
- I. Please do not give the product any excessive mechanical shocks in transportation.
- m. Please do not touch wires by sharp terminals such as tweezers to avoid causing any damage to wires.
- n. Please do not add any shock and power to the soldered product to avoid causing any damage to chip body.
- o. Please do not touch the electrodes by naked hand as the solderability of the external electrodes may deteriorate by grease or oil on the skin.

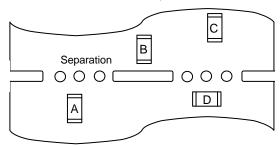
7.2 PCB Bending Design

The following shall be considered when designing and laying out PCB's.

a. PCB shall be designed so that products are not subjected to the mechanical stress from board warp or deflection.



b. Products location on PCB separation.



Product shall be located carefully because they may be subjected to the mechanical stress in order of A>C=B>D.

c. When splitting the PCB board, or insert (remove) connector, or fasten thread after mounting components, care is required so as not to give any stress of deflection or twisting to the board. Because mechanical force may cause deterioration of the bonding strength of electrode and solder, even crack of product body. Board separation should not be done manually, but by using appropriate devices.

7.3 Recommended PCB Design for SMT Land-Patterns

When chips are mounted on a PCB, the amount of solder used (size of fillet) and the size of PCB Land-Patterns can directly affect chip performance (such as Q). And they can also cause other soldering question (such as offset and side lap). Therefore, the following items must be carefully considered in the design of solder land patterns.

- Please use the PCB pad and solder paste we recommend, and contact us in advance if they need to be changed.
- b. Please use flux contained with resin since the highly acidic (Chlorine content more than 0.2 wt%) or water-soluble one could damage the insulation film of wires, then causing short circuit of parts.
- c. The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets.
- d. When more than one part is jointly soldered onto the same land or pad, the pad must be designed that each component's soldering point is separated by solder-resist.

Recommended land dimensions please refer to product specification.

8. Recommended Soldering Technologies

This product is only for reflow soldering and iron soldering.

8.1 Re-flowing Profile

△ Preheat condition: 150~200°C/60~120sec.

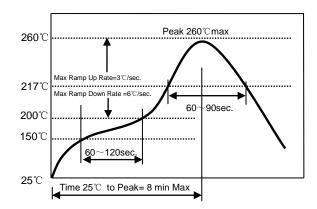
△ Allowed time above 217C: 60~90sec.

△ Max temp: 260°C

 \triangle Max time at max temp: 10sec.

△ Solder paste: Sn/3.0Ag/0.5Cu

△ Allowed Reflow time: 2 times max.



[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

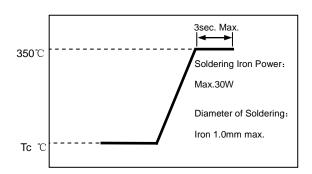
8.2 Iron Soldering Profile

 \triangle Iron soldering power: 30W Max.

 \triangle Preheat condition: 150 $^{\circ}$ C/60sec.

△ Soldering tip temperature: 350°C Max.

△ Soldering time: 3sec. Max.
 △ Solder paste: Sn/3.0Ag/0.5Cu
 △ Iron Soldering time: 1 time max.



[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]

8.3 Maintenance of heat gun (for your reference)

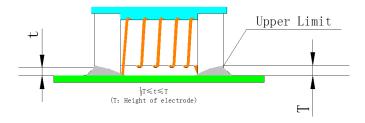
△ Power output: 30W

∆ Temperature: 350°C Max

 \triangle Heat time: More than 5 seconds heating may cause short circuit of parts.

9. Solder Volume

Solder shall be used not to exceed as shown below.



- a. Accordingly increasing the solder volume, the mechanical stress to chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance.
- b. Before soldering, please ensure that the solder should not adhere to the wire part of chip.
- c. Please pay particular attention to whether there is flux remaining on surface of the wire part of chip after subjected to reflow soldering since this may causing short circuit of parts.

10. Cleaning

Products shall be cleaned on the following conditions:

- Cleaning temperature shall be limited to 60°C Max. (40°C Max. for fluoride and alcohol type cleaner.)
- Ultrasonic cleaning shall comply with the following conditions, avoiding the resonance phenomenon at the mounted products and PCB.

Power: 20W/I Max.

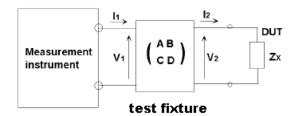
Frequency: 28 KHz to 40 KHz

Time: 5 minutes Max

- c. Cleaner
 - i. Alternative cleaner
 - Isopropyl alcohol (IPA)
 - HCFC-225
 - ii. Aqueous agent
 - Surface Active Agent Type (Clean through-750H)
 - Hydrocarbon Type (Techno Cleaner-335)
 - Higher Alcohol Type (Pine Alpha ST-100S)
 - Alkali saponifier Type (X Aqua Cleaner 240)
 - X Alkali saponification shall be diluted to 20% volume with de-ionized water.
 - * Please contact our technical service department before using other cleaner.
- d. There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, product shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- e. Some products may become slightly whitened. However, product performance or usage is not affected.
- f. Please take care of winding part while cleaning.
- g. After cleaning, parts could be subjected to the next reflow soldering till the solvent remaining on surface of parts being volatilized.

11. Measuring Method of Inductance

a. Residual elements and stray elements of test fixture can be described by F-parameter as shown in the following:



$$\begin{bmatrix} V_1 \\ I_1 \end{bmatrix} = \begin{bmatrix} A & B \\ C & D \end{bmatrix} \begin{bmatrix} V_2 \\ I_2 \end{bmatrix}$$
$$\begin{bmatrix} V_1 \\ I_1 \end{bmatrix} = \begin{bmatrix} AV_2 + BI_2 \\ CV_2 + DI_2 \end{bmatrix}$$

Measured open impedance: $Zom = \frac{A}{C}$

Measured short impedance: $Z_{SM} = \frac{B}{D} \approx -Z_{SC}$ (when uses short chip to short)

Measured short ship impedance: Zsc

Measured value: $Zxm=V_1/I_1$ Impedance of DUT: $Zx=V_2/I_2$

b. The relation between Zx and Zom, Zsm, Zxm is shown in the following:

$$Zx = \frac{V_2}{I_2} = \frac{D}{A} * \frac{\frac{V_1}{I_1} - \frac{B}{D}}{1 - \frac{V_1}{I_1} * \frac{C}{A}} = \frac{D}{A} * \frac{Zxm - \frac{B}{D}}{1 - Zxm * \frac{C}{A}} = \frac{D}{A} * \frac{Zxm - Zsm}{1 - Zxm / Zom}$$

c. Lx should be calculated with the following equation:

$$Lx = \frac{\operatorname{Im}(Zx)}{2\pi f} = \frac{\operatorname{Im}(Zxm + Zsc)}{2\pi f} = \frac{\operatorname{Im}(Zxm)}{2\pi f} + \frac{\operatorname{Im}(Zsc)}{2\pi f} = Lxm + Lsc$$

Lxm: measured chip inductor inductance
Lsc: measured short chip inductance
Lx: Inductance of chip inductor

d. Compensation Value (Lsc) of short chip

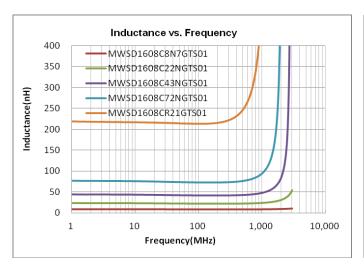
Dort Number	Commonation Value (nII)	Managina francisco (MIII)		
Part Number	Compensation Value (nH)	Measuring frequency (MHz)		
MWSD1608C3N3 TS01	0.111	250		
MWSD1608C3N6 TS01	0.231	250		
MWSD1608C3N9 TS01	0.011	250		
MWSD1608C4N7□TS01	0.301	250		
MWSD1608C5N1 □TS01	0.071	250		
MWSD1608C5N6□TS01	-0.079	250		
MWSD1608C6N8□TS01	-0.019	250		
MWSD1608C7N5□TS01	0.201	250		
MWSD1608C8N2□TS01	0.281	250		
MWSD1608C8N7□TS01	0.221	250		
MWSD1608C9N5□TS01	0.021	250		
MWSD1608C10N□TS01	-0.089	250		
MWSD1608C11N□TS01	0.321	250		
MWSD1608C12N□TS01	-0.189	250		
MWSD1608C15N□TS01	-0.369	250		
MWSD1608C16N□TS01	0.271	250		
MWSD1608C18N□TS01	-0.429	250		
MWSD1608C22N□TS01	-0.419	250		
MWSD1608C23N□TS01	-0.509	250		
MWSD1608C24N□TS01	0.401	250		
MWSD1608C27N□TS01	0.171	250		
MWSD1608C30N□TS01	-0.219	250		
MWSD1608C33N□TS01	-0.589	250		
MWSD1608C36N□TS01	-0.299	250		
MWSD1608C39N□TS01	-0.859	250		
MWSD1608C43N□TS01	0.231	250		
MWSD1608C47N□TS01	-0.769	200		
MWSD1608C51N□TS01	-0.949	200		
MWSD1608C56N□TS01	-1.299	200		
MWSD1608C68N□TS01	-1.739	200		
MWSD1608C72N□TS01	-1.089	150		
MWSD1608C82N□TS01	-1.909	150		
MWSD1608CR10□TS01	-1.729	150		
MWSD1608CR11 □TS01	-2.829	150		
MWSD1608CR12□TS01	-3.429	150		
MWSD1608CR15□TS01	-4.429	150		
MWSD1608CR18□TS01	-5.129	100		
MWSD1608CR20□TS01	-4.629	100		
MWSD1608CR21 □TS01	-2.029	100		
MWSD1608CR22□TS01	-5.229	100		
MWSD1608CR25□TS01	-4.029	100		
MWSD1608CR27□TS01	-4.329	100		
MWSD1608CR33□TS01	-8.329	100		
MWSD1608CR39□TS01	-13.329	100		
	10.020	100		

Appendix A: Electrical Characteristics
I MWSD1608C ☐ ☐ ☐ ☐ TS01 Series

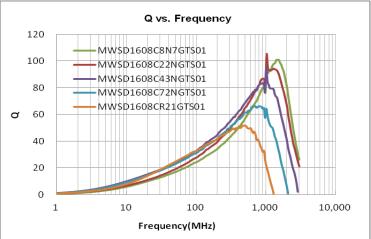
Part Number	Inductance	Tolerance	Min. Quality Factor	L/Q Test Freq.	Max. DC Resistance	Max. Rated Current	Min. Self- resonant Frequency
Units	nH	-	_	MHz	Ω	mA	MHz
Symbol	L	•	Q	Freq.	DCR	lr	S.R.F
MWSD1608C3N3□TS01	3.3	D	35	250/250	0.045	700	5900
MWSD1608C3N6□TS01	3.6	C, D	22	250/250	0.063	700	5900
MWSD1608C3N9□TS01	3.9	C, D	22	250/250	0.080	700	6900
MWSD1608C4N7□TS01	4.7	D	20	250/250	0.116	700	5800
MWSD1608C5N1 □TS01	5.1	D	20	250/250	0.140	700	5700
MWSD1608C5N6□TS01	5.6	C, D	26	250/250	0.075	700	4760
MWSD1608C6N8□TS01	6.8	C, D	27	250/250	0.110	700	5800
MWSD1608C7N5□TS01	7.5	C, D	28	250/250	0.106	700	4800
MWSD1608C8N2□TS01	8.2	C, D	30	250/250	0.115	700	4200
MWSD1608C8N7□TS01	8.7	C, D	28	250/250	0.109	700	4600
MWSD1608C9N5□TS01	9.5	G ,J	28	250/250	0.135	700	5400
MWSD1608C10N□TS01	10	G ,J	31	250/250	0.130	700	4800
MWSD1608C11N□TS01	11	G ,J	30	250/250	0.086	700	4000
MWSD1608C12N□TS01	12	G ,J	35	250/250	0.130	700	4000
MWSD1608C15N□TS01	15	G ,J	35	250/250	0.170	700	4000
MWSD1608C16N□TS01	16	G ,J	34	250/250	0.104	700	3300
MWSD1608C18N□TS01	18	G ,J	35	250/250	0.170	700	3100
MWSD1608C22N□TS01	22	G ,J	38	250/250	0.190	700	3000
MWSD1608C23N□TS01	23	G ,J	38	250/250	0.190	700	2850
MWSD1608C24N□TS01	24	G ,J	36	250/250	0.135	700	2650
MWSD1608C27N□TS01	27	G ,J	40	250/250	0.220	600	2800
MWSD1608C30N□TS01	30	G ,J	37	250/250	0.144	600	2250
MWSD1608C33N□TS01	33	G ,J	40	250/250	0.220	600	2300
MWSD1608C36N□TS01	36	G, J	37	250/250	0.250	600	2080
MWSD1608C39N□TS01	39	G ,J	40	250/250	0.250	600	2200
MWSD1608C43N□TS01	43	G ,J	38	250/250	0.280	600	2000
MWSD1608C47N□TS01	47	G ,J	38	200/200	0.280	600	2000
MWSD1608C51N□TS01	51	G ,J	35	200/200	0.270	600	1900
MWSD1608C56N□TS01	56	G ,J	38	200/200	0.310	600	1900
MWSD1608C68N□TS01	68	G ,J	37	200/200	0.340	600	1700
MWSD1608C72N□TS01	72	G ,J	34	150/150	0.490	400	1700
MWSD1608C82N□TS01	82	G ,J	34	150/150	0.540	400	1700
MWSD1608CR10□TS01	100	G ,J	34	150/150	0.580	400	1400
MWSD1608CR11□TS01	110	G ,J,	32	150/150	0.610	300	1350
MWSD1608CR12□TS01	120	G ,J	32	150/150	0.650	300	1300
MWSD1608CR15□TS01	150	G ,J	28	150/150	0.920	280	990
MWSD1608CR18□TS01	180	G ,J	25	100/100	1.250	240	990
MWSD1608CR20□TS01	200	G ,J	25	100/100	1.980	200	900
MWSD1608CR21□TS01	210	G ,J	27	100/100	2.060	200	895
MWSD1608CR22□TS01	220	G ,J	25	100/100	2.100	200	900
MWSD1608CR25□TS01	250	G ,J	25	100/100	3.550	120	822
MWSD1608CR27□TS01	270	G ,J	24	100/100	2.300	170	900
MWSD1608CR33□TS01	330	G ,J	25	100/100	3.890	100	900
MWSD1608CR39□TS01	390	G ,J	25	100/100	4.350	100	900

II. Typical Electrical Characteristics

Inductance vs. Frequency Characteristics



Q vs. Frequency Characteristics



Appendix B: Appearance standard

File No:		Applied to	Wire Wound Caromic Industor Series			
Effective date:		Applied to Wire Wound Ceramic Inductor Series				
No.	Defect Item Item	Graphic Schematic Drawing	Rejection identification Criteria			
1	Wire off/ Welding Spot Off		The solder joint Welding Spot of wire break away from electrodes, or over the electrodes.			
2	Solder misplace		Solder joints are not at electrode side but at the coating side or flank.			
3	Coating misplace		Coating at flank			
			Coating at electrodes side			